

Notice of References Cited

Application/Control No.

10/040,144

Applicant(s)/Patent Under
Reexamination
LOW ET AL.

Examiner

Hien Tran

Art Unit

1764

Page 1 of 1

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-3,556,735	01-1971	Epelman	422/171
B	US-3,913,890	10-1975	Lankenau et al.	422/176
C	US-4,422,790	12-1983	Gebert et al.	403/11
D	US-5,788,729	08-1998	Jurgensmeyer, Ken	55/496
E	US-			
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	
V	
W	
X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.